Analysis of SPDEs and numerical methods for UQ

Part I: Background, motivation and "tools of the trade"

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Thanks to Max Gunzburger & Guannan Zhang (FSU), Fabio Nobile (MOX), Raul Tempone (KAUST)

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April 2-3, 2012

Outline

Why stochastic models?

A transition to non-deterministic simulations

Many applications (especially those predicting future events) are affected by a relatively large amount of uncertainty in the input data such as model coefficients, forcing terms, boundary conditions, geometry, etc.

- An example includes forecasting financial markets where this may depend on the number of economic factors, number of underlying assets or the number of time points/time steps, human behaviors, etc.
- Important DOE examples include the enhancement of reliability of smart energy grids, development of renewable energy technologies, vulnerability analysis of water and power supplies, understanding complex biological networks, climate change estimation and design and licensing of current and future nuclear energy reactors (CASL simulation hub)
- The model itself may contain an incomplete description of parameters, processes or fields (not possible or too costly to measure)
- There may be small, unresolved scales in the model that act as a kind of background noise (i.e. macro behavior from micro structure)

All these and many others introduce uncertainty in mathematic models

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Types of uncertainties

Stochastic models give quantitative information about uncertainty. In practice it is necessary to address the following types of uncertainties:

- Uncertainty may be *aleatoric* which means random and is due to the intrinsic variability in the system
  Remark: by variability we mean a type of uncertainty that is inherent and irreducible, e.g. turbulent fluctuations of a flow field around an airplane wing, permeability in an aquifer, etc.
  OR
- Uncertainty may be *epistemic* which means due to incomplete knowledge
  Remark: can be reduced by additional experimentation, improvements in measuring devices, etc., e.g. mechanic properties of many bio-materials, polymeric fluids, highly heterogeneous or composite materials, the action of wind or seismic vibrations on civil structures, etc.

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Uncertainty quantification (UQ)

Worst scenario approaches

Let A denote the input data and B the output set such that $u : A \mapsto B$. There are various ways to describe the uncertainty in A with the **goal** of describing the uncertainty in some quantity of interest (QoI) $Q(u)$:

Worst scenario approaches: Typically A is an ϵ-ball around some nominal input data and the goal is to determine the worst case associated with the set relation $B = u(A)$

The range of the uncertainty of $Q(u)$ is then defined by the interval I

$$I = [\underline{Q}(u), \overline{Q}(u)] = \left[\inf_{a \in A} Q(u(a)), \sup_{a \in A} Q(u(a))\right]$$

- the choice of the input set A is, in a large way, subjective and should be regarded as a working assumption

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Uncertainty quantification (UQ)

Knowledge-based methods

Fuzzy sets and possibility theory: deterministic approach to UQ which generalizes classical set theory. Let $C \subset A$:

- for each $x \in A$ set membership is defined by $\mu_C : A \to [0,1]$, expressing the degree of truth of the statement "x belongs to C."
- define the α-cut of C by $C_\alpha \stackrel{\text{def}}{=} \{x \in A : \mu_C \geq \alpha\}$ which gives a set characterization of uncertainty
- the operator u then propagates the fuzziness in A into the fuzziness in B

Evidence theory (Dempster-Shafer Theory): generalizing the probabilistic approach by defining the Belief $Bel(C)$ (lower bound) and Plausibility $Pl(C)$ (upper bound) functions, for the likelihood of an event C.

- define the likelihood $m : \Phi \to [0,1]$ of a countable family of events Ψ

$$\sum_{\varphi \in \Phi} m(\varphi) = 1, \quad m(\emptyset) = 0, \quad \text{however } \varphi_1 \subset \varphi_2 \not\Rightarrow m(\varphi_1) \leq m(\varphi_2)$$

$$Bel(C) = \sum_{\varphi \in \Phi, \varphi \subset C} m(\varphi), \quad Pl(C) = \sum_{\varphi \in \Phi, \varphi \cap C \neq \emptyset} m(\varphi)$$

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Stochastic/Probabilistic methods

What is probability theory? Understood as a mathematical theory of a finite measure. Let $(\Omega, \mathscr{F}, \mathbb{P})$ denote a (complete) probability space: Ω is the event space, $\mathscr{F} \subset 2^{\Omega}$ is the σ-algebra and $\mathbb{P}$ is the probability measure, satisfying:

1. $0 \leq P(A),$ if $A \in \mathscr{F}$ and $P(\Omega) = 1$
2. A **positive measure** $\mathbb{P} : \mathscr{F} \to [0, 1]$ which is countably additive

$$\mathbb{P}\left(\bigcup_{i=1}^{\infty} A_i\right) = \sum_{i=1}^{\infty} \mathbb{P}(A_i), \text{ for } \{A_i\}_{i=1}^{\infty} \in \mathscr{F} \text{ disjoint}$$

Stochastic / probabilistic methods: given a probability measure on the input data A the mapping u induces a probability measure on the output set $B \Longrightarrow$ SODEs/SPDEs (**Doob-Dynkin Lemma**)

- applies to aleatoric phenomena, i.e. frequencies of occurance
- applies to epistemic concepts in the realm of Bayesian and maximum entropy methods

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Stochastic models

Models (linear or nonlinear) for a system $\mathcal{M}$ may be stationary with state u, exterior loading or forcing f and random model description (realization) $\omega \in \Omega$, with probability measure $\mathbb{P}$:

$$\mathcal{M}(\omega; u) = f(\omega) \quad \text{a.e. in } D \subset \mathbb{R}^d$$

Evolution in time may be

- discrete (e.g. Markov chain), driven by discrete random process:

$$u_{n+1} = \mathcal{F}(\omega; u_n)$$

- continuous (e.g. Markov process $\equiv$ Stochastic Differential Equation), driven by random processes:

$$du = (\mathcal{M}(\omega; u) - f(\omega, t))dt + \mathcal{B}(\omega; u)dW(\omega, t) + \mathcal{P}(\omega; u)dQ(\omega, t).$$

In this Itô evolution equation, $W(\omega, t)$ is a Wiener process and $Q(\omega, t)$ is a Poisson process.

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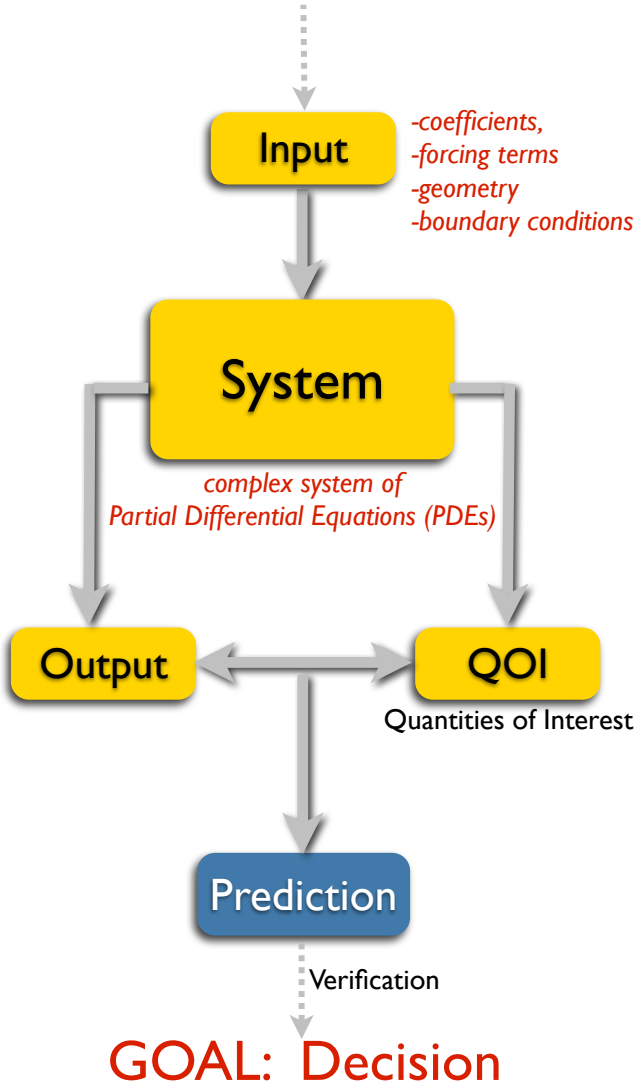
The Computational Stochastic PDE

Forward Problem: From Real World to Predictions to Decisions



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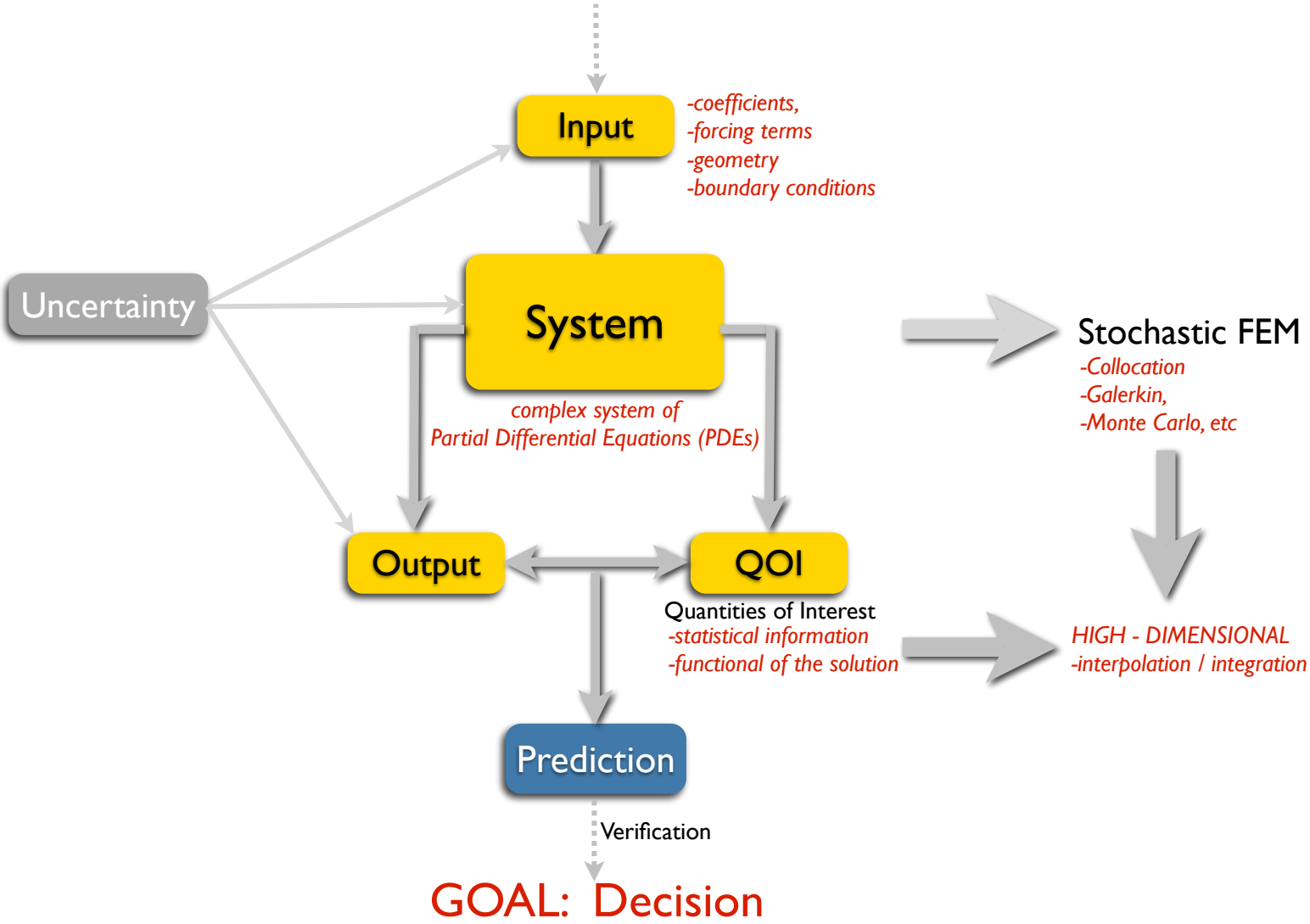

An example problem

Pressure distribution in a porous medium

Consider the following simple equation describing the pressure distribution in a porous medium:

$$\begin{cases} -\nabla \cdot (a(x)\,\nabla u(x)) &= f(x) & \text{in } D \subset \mathbb{R}^d, \\ u(x) &= 0 & \text{on } \partial D, \end{cases}$$

where $f(x)$ is the source, $a(x)$ describes the permeability and $u(x)$ is the pressure distribution.

Q: What if the input data is random?

$$\begin{cases} -\nabla \cdot (a(\omega,x)\,\nabla u(\omega,x)) &= f(\omega,x) & \text{in } \Omega \times D, \\ u(\omega,x) &= 0 & \text{on } \Omega \times \partial D, \end{cases}$$

where $f(\omega,x)$ is the stochastic source, $a(\omega,x)$ describes the stochastic permeability and $u(\omega,x)$ is the stochastic pressure distribution.

- Difficulties arise since instead of just asking for $u(x_0)$ we instead want to know $\mathbb{E}[u](x_0)$, $\mathbb{V}ar[u](x_0)$ or even $\mathbb{P}[u(\omega,x_0) \geq u_0]$

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General approaches I

There have been many formulations and approaches to solve SPDEs:

- **Statistical sampling methods:**
  - *Brute-force* Monte Carlo (MC): convergence rate independent of the number of random variables, robust, embarrassingly parallel - very slow convergence ($1/\sqrt{\#\text{samples}}$)
  - Quasi MC (QMC), Latin Hypercube Sampling (LHS), Lattice Rules
  - Variance reduction techniques: important, conditional and correlated sampling - limitations when confronted with large number of RVs
- **Indirect methods** (require closure approx.):
  - Moment methods: derive equations for the **moments** of the quantities of interest - not applicable to nonlinear problems or non-Gaussian RVs
  - PDEs for PDFs (e.g. Fokker-Planck equation): derive a system of PDEs whose solution approximates the probability distributions / densities - BCs and higher dimensions are challenging

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General approaches II

- **Direct methods**: compute an approximation to $u(\omega, x)$ in a suitable subspace and use this solution to compute the desired statistics, e.g. Stochastic Galerkin, Stochastic Collocation.
  - Interval analysis : maximum bounds of output uncertainty - can dramatically overestimated to uncertainties
  - Perturbation-based methods : Taylor expansion around a mean solution - can only be used for linear QoIs and when the variance in solution is small
  - Operator-based methods : compute the inverse of a given operator, if it exists, by using a Neumann series expansion or the weighted integral method - restricted to small magnitude uncertainties and often limited to static problems
  - Stochastic polynomial approximations: spectral Galerkin, Wiener (polynomial) chaos, Karhunen-Loève , stochastic collocation - challenges include: determining the proper polynomial subspace, *curse of dimensionality*, adaptive and anisotropic refinement, low stochastic regularity and discontinuities, optimization and inverse problems

Plan of attack

1. Determine an accurate representation for the input stochastic (random) fields can be both simulated and analyzed. e.g. a Karhunen-Loève expansion
2. Transform the stochastic problem into a **deterministic**, parametric one in $\mathbb{R}^d \times$ an $\infty-$ dimensional space
3. Design an adaptive **dimensional reduction** procedure
4. Design an adaptive **discretization** procedure using sampling methods, polynomial (spectral) methods or a combination of both
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Tools of the trade

Random variables and random fields

The input data $a(\omega, x)$, $f(\omega, x)$ and the solution $u(\omega, x)$ of the SPDE will (more than likely) be a random field defined by a set of random variables $\mathbf{Y}(\omega) = (Y_1(\omega), \ldots, Y_N(\omega))$, i.e. $u(\omega, x) = u(\mathbf{Y}(\omega), x)$

1. How to deal with RVs $Y_n(\omega)$?
2. How to represent RFs $a(\mathbf{Y}(\omega), x)$, $f(\mathbf{Y}(\omega), x)$ and $u(\mathbf{Y}(\omega), x)$?

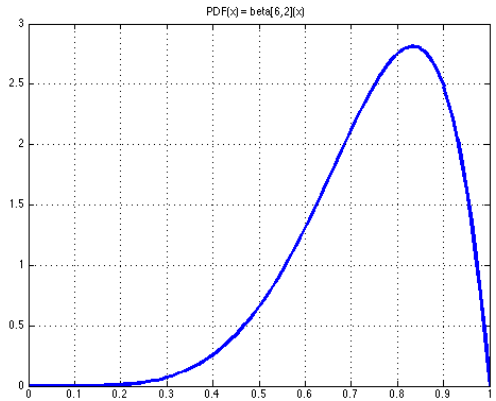
Tools of the trade

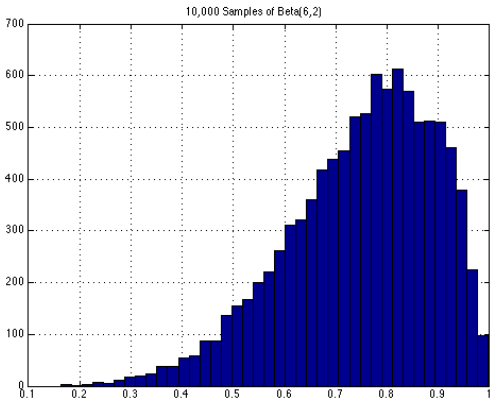
Random variables

A $\mathbb{R}$-valued random variable (RV) $Y : (\Omega, \mathscr{F}, \mathbb{P}) \to \mathbb{R}$ is completely specified by a probability density function (pdf) ρ_Y and a cumulative distribution function (cdf) and F_Y s.t. $\forall y \in \mathbb{R}$:

$$F_Y(\lambda) := \mathbb{P}\left[\{Y(\omega) \leq \lambda\}\right] = \int_{\{Y(\omega)\leq\lambda\}} d\mathbb{P}(\omega) = \mathbb{E}\left[\chi_{\{Y(\omega)\leq\lambda\}}\right]$$
$$= \int_{-\infty}^{\lambda} \rho_Y(y)dy,$$

where $\int_{\mathbb{R}} \rho_Y(y)dy = 1$





Random variables

Covariance, correlation and independence

For $Y \in L^1_{\mathbb{P}}(\Omega)$ define the expected (mean) by

$$\overline{Y} = \mathbb{E}[Y] = \int_\Omega Y(\omega) d\mathbb{P}(\omega) = \int_{\mathbb{R}} y \rho_Y(y) dy$$

and fluctuating part by $\widetilde{Y} = Y(\omega) - \overline{Y}(\omega)$, with $\mathbb{E}[\widetilde{Y}] = 0$.

- The variance $\mathbb{V}ar[Y] = \mathbb{E}\left[\widetilde{Y} \otimes \widetilde{Y}\right] = \mathbb{E}\left[(\widetilde{Y})^2\right] = \mathbb{C}ov[Y, Y]$
- Let $\mathbf{Y}(\omega) = (Y_n(\omega))_{n=1}^N, N \in \mathbb{N}_+$ be a random vector, then the covariance and correlation of two RVs:

$$\mathbb{C}ov[Y_i, Y_j] := \mathbb{E}\left[\widetilde{Y_i} \otimes \widetilde{Y_j}\right], \quad \mathbb{C}orr = \frac{\mathbb{C}ov[Y_i, Y_j]}{\sqrt{\mathbb{V}ar[Y_i]}\sqrt{\mathbb{V}ar[Y_j]}}$$

- uncorrelated if $\mathbb{C}ov[Y_i, Y_j] = 0$ (orthogonal), perfectly correlated if $\mathbb{C}orr = 1$ and perfectly anti-correlated if $\mathbb{C}orr = -1$
- independent if $\forall \phi_1, \phi_2$, $\mathbb{E}[\phi_1(X_1)\phi_2(X_2)] = \mathbb{E}[\phi_1(X_1)]\mathbb{E}[\phi_2(X_2)]$

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  - independent if $\forall \phi_1, \phi_2$, $\mathbb{E}[\phi_1(X_1)\phi_2(X_2)] = \mathbb{E}[\phi_1(X_1)]\mathbb{E}[\phi_2(X_2)]$

Random variables

Covariance matrix for vectors

We can now define a covariance matrix $\mathbb{C}ov[\mathbf{Y}]$ whose (i,j) entry is the covariance between $Y_i(\omega)$ and $Y_j(\omega)$:

$$\mathbb{C}ov[\mathbf{Y}]_{(i,j)} = \mathbb{C}ov[Y_i, Y_j]$$

- $\mathbb{C}ov[\mathbf{Y}]$ is symmetric, nonnegative definite, and has diagonal elements $\mathbb{C}ov[\mathbf{Y}]_{(i,i)} = \mathbb{V}ar[Y_i]$

As before, the correlation matrix can be defined from the covariance matrix. Form a diagonal matrix Σ from the square roots of the variances, then compute the correlation matrix by:

$$\mathbb{C}orr[\mathbf{Y}] = \Sigma^{-1}\mathbb{C}ov[\mathbf{Y}]\Sigma$$

- the diagonal entries of $\mathbb{C}orr[\mathbf{Y}]$ are 1
- The Cauchy-Schwarz inequality guarantees that the off-diagonal elements lie between -1 and $+1$
- value of each covariance entry indicates the strength and direction of the correlation between the corresponding components

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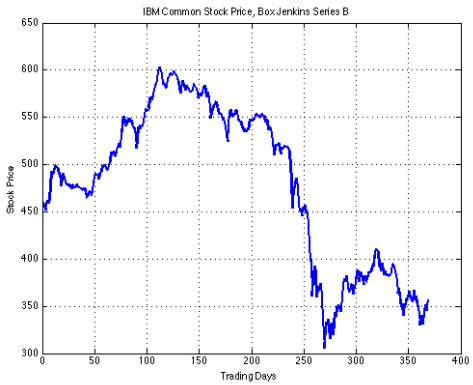
Tools of the trade

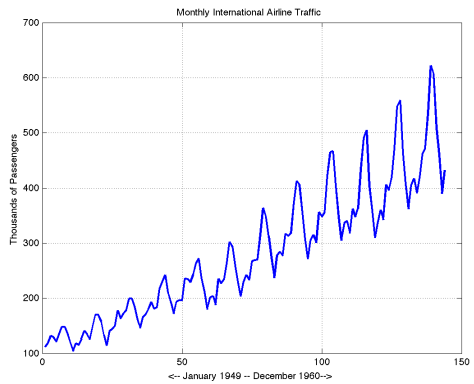
Random processes/fields: generalizations of RVs

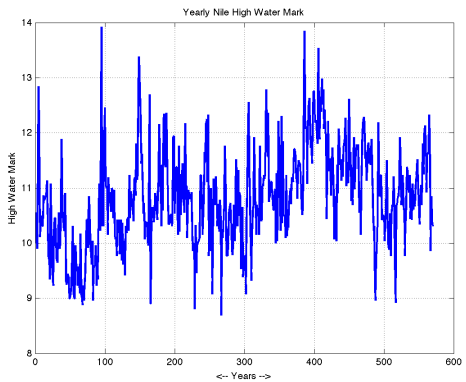
A random process/field (RP/RF) $a(\omega, x)$ defined on a probability space $(\Omega, \mathscr{F}, \mathbb{P})$ and indexed by a deterministic domain $D \subset \mathbb{R}^d$, returns a real value

1. a set of RVs indexed by $x \in D$. For every $x \in D$, $a(\cdot, x)$ is a RV on Ω
2. a function-valued RV. For every $\omega \in \Omega$, $a(\omega, \cdot)$ is a random function - a realization - of x in the domain D

Often only second order information - mean and covariance are known







- Mean $\overline{a}(x) = \mathbb{E}[a](x) = \int_\Omega a(\omega, \cdot) d\mathbb{P}(\omega)$ and $\mathbb{V}ar[a](x) = \mathbb{E}[(\widetilde{a})^2](x)$ as a function of x with fluctuation part $\widetilde{a}(\omega, x) = a - \overline{a}$
- $\mathbb{P}[a \geq a_0] = \mathbb{P}[\{\omega \in \Omega : a(\omega, x) \geq a_0\}] = \mathbb{E}\left[\chi_{\{a \geq a_0\}}\right]$

Random fields (RF)

White vs. colored noise

The covariance may be considered at different spatial positions $x \in D \subset \mathbb{R}^d$:

$$\mathbb{C}ov[a](x_1, x_2) := \mathbb{E}\left[\widetilde{a}(\cdot, x_1)\widetilde{a}(\cdot, x_2)\right], \text{ for } x_1, x_2 \in D \times D$$

- if $\overline{a}(x) \equiv \overline{a}$ and $\mathbb{C}ov[a](x_1, x_2) = C_a(x_1 - x_2)$ then the process is homogeneous. Here representation through the spectrum using Fourier expansion if **well known**
- we will consider colored noise approximations using correlated second-order RFs: $a(\omega, x) \in L^2_{\mathbb{P}}(\Omega; W(D))$ where

$$L^2_{\mathbb{P}} := \left\{ a \text{ measurable and } \int_\Omega \|a(\omega, \cdot)\|^2_{W(D)} d\mathbb{P}(\omega) < +\infty \right\}$$

  and $W(D)$ a Banach space of functions $a : D \to \mathbb{R}$
- we will not focus on white noise approximations which refers to uncorrelated RFs for which:

$$\overline{a}(x) = 0 \text{ and } \mathbb{C}ov[a](x_1, x_2) = \delta(x_1 - x_2)$$

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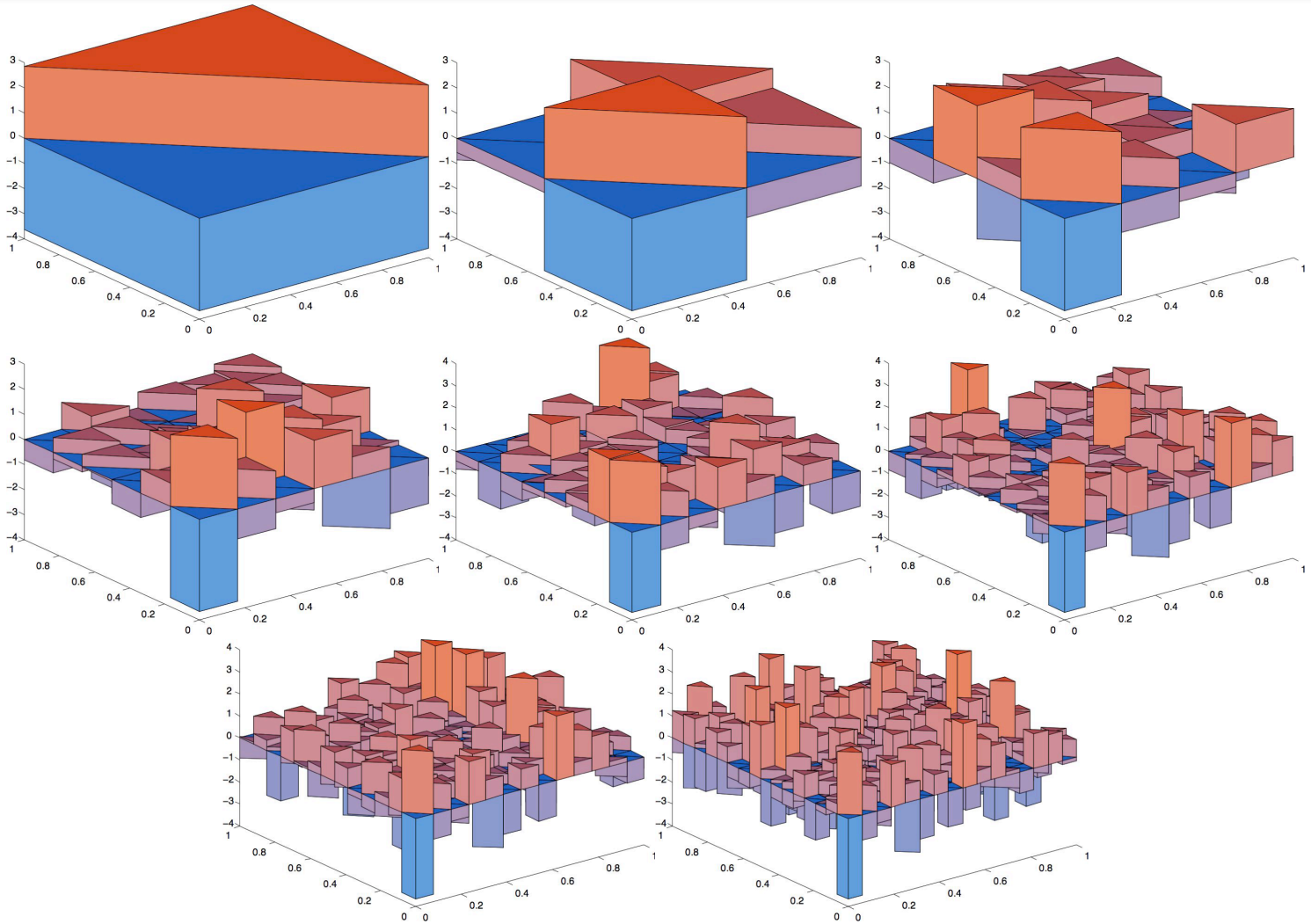
Discretized white noise

Piecewise constant approximations



Discretized white noise over a square subdivided into $2, \ldots, 512$ triangles

Random fields (RF)

Finite dimensional noise assumption

Given the mean and covariance of the RF we would like to construct a simple representation which captures this information and used for simulations

- Ideally, this involves a combination of countably many independent RVs
  - $\Gamma_n \equiv Y_n(\Omega) \subset \mathbb{R}$ and $\Gamma = \prod_{n=1}^{N} \Gamma_n \subset \mathbb{R}^N$, the image of the random vector $\mathbf{Y} = (Y_1, \ldots, Y_N)$
  - Let $\rho : \Gamma \to \mathbb{R}_+$, with $\rho \in L^\infty(\Gamma)$ be the joint probability density function (jPDF) of $\mathbf{Y}$, then we want that:

$$\rho(\mathbf{y}) = \prod_{n=1}^{N} \rho_n(y_n), \text{ where } \mathbf{y} \in \Gamma \text{ and } \forall n, y_n \in \Gamma_n$$

- The independence of the N RVs allows to see each of them as the axis of a coordinate system (Doob-Dynkin lemma)
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Motivate the Karhunen-Loève expansion

SVD: The Singular Value Decomposition

Every (real) m by n matrix A has a singular value decomposition:

$$A = U\,S\,V^T$$

where

- U is an m by m orthogonal matrix $(U^T\,U = I)$;
- S is an m by n diagonal matrix with nonnegative entries;
- V is an n by n orthogonal matrix;

The diagonal entries of S, called the singular values of A, are chosen to appear in descending order, and are equal to the square roots of the nonzero eigenvalues of AA^T or $A^T\,A$

SVD

Facts about the SVD I

- r, the number of nonzero diagonal elements in S, is the rank of A
  - very small nonzeros may indicate numeric singularities
- the i-th diagonal element of S is the i-th largest eigenvalue of AA^T (and also of AA^T). Hence, we may write this value as $\sqrt{\lambda_i}$.
- Let u_i and v_i^T be the i-th columns of U and V^T. Then A maps the i-th column of V^T to the i-th column of U.
- The columns of U and V provide a singular value expansion of A:

$$A = \sum_{i=1}^{r} \sqrt{\lambda_i}\, u_i\, v_i^T$$

SVD

Facts about the SVD II

If we use all r terms, the singular value expansion is exact

Let A^k represent the sum of just the first k terms of the expansion

- A^k is a matrix of rank k, the sum of k rank-1 outer products
- Of all rank k matrices, A^k is the best approximation to A in two senses:

1. Minimum L^2 norm:

$$\left\|A - A^k\right\|_{L^2} \equiv \text{square root of maximum eigenvalue of } (A - A^k)^T (A - A^k)$$

$$\left\|A - A^k\right\|_{L^2}^2 = s_{k+i}^2 = \lambda_{k+1}$$

2. Minimum Frobenius (sum of squares) norm:

$$\left\|A - A^k\right\|_F \equiv \sqrt{\sum_{i,j} (A_{i,j} - A_{i,j}^k)^2}$$

$$\left\|A - A^k\right\|_F^2 = \sum_{k+1}^{r} s_i^2 = \sum_{k+1}^{r} \lambda_i$$

SVD

Using the facts I

U and V are natural bases for the input and output of A

In the natural bases, the SVD shows that multiplying by A is simply stretching the i-th component by s_i:

$$x = \sum_{i=1}^{r} v_i^T * c_i \implies y = A * x = \sum_{i=1}^{r} u_i * (s_i * c_i)$$

- The relative size of the singular values indicates the importance of each column
- The singular value expansion produces an optimal, indexed family of reduced order models of A

SVD

Using the facts II

- SVD is the discrete version of the Karhunen-Loève (KL) expansion that is typically applied to RF that produce, for any time t, a field of values varying spatially with x
- Since it's easier to understand discrete problems, let's prepare for the KL expansion by looking at how the SVD is used with a set of data
- Let us re-imagine the columns of our discrete data as being n snapshots in discrete time indexed by j. Each snapshot will record m values in a "space" indexed by i

SVD

- If we pack our data into a single matrix A, then $A_{i,j}$ means the measurement at position i and time j
- It is reasonable to expect correlation in this data; the "neighbors" of $A_{i,j}$, in either space or time, might tend to have similar values
- Moreover, the overall "shape" of the data for one time or one spatial coordinate might be approximately repeated elsewhere in the data
- This is exactly the kind of behavior the SVD can detect

	Space							
Time								
1890	1	12	12	33	29	22	3	0
1891	0	31	23	44	18	13	1	0
1892	0	23	44	25	17	17	13	1
1893	1	30	49	37	15	23	10	1
1894	0	30	18	74	9	5	0	2

SVD example

Snowfall at Michigan Tech

We have a data file of the monthly snowfall in inches, over 121 winters at Michigan Tech. We'll think of the months as the "space" dimension.

Year	Oct	Nov	Dec	Jan	Feb	Mar	Apr	May	Tot
1890	1	12	12	33	29	22	3	0	112
1891	0	31	23	44	18	13	1	0	130
1892	0	23	44	25	17	17	13	1	140
1893	1	30	49	37	15	23	10	1	166
1894	0	30	18	74	9	5	0	2	138
....	....	....	....	....	....	....	....	....	....
2006	6	6	27	38	37	20	31	0	165
2007	0	21	40	55	32	24	14	0	186
2008	0	17	70	85	27	5	15	0	219
2009	3	4	87	39	19	0	0	0	152
2010	0	26	33	72	18	13	18	0	180

http://www.mtu.edu/alumni/favorites/snowfall/snowfall.html

SVD example

Snowfall at Michigan Tech

To analyze our data, we consider each of the 121 snowfall records, starting with x^{1890}, as a column of 8 numbers, and form the m=8 by n=121 matrix A:

$$A = \left[x^{1890}|x^{1891}|...|x^{2010}\right]$$

- Now we determine the SVD decomposition $A = USV^T$
- The columns of U are an orthogonal set of "spatial" behaviors or modes (typical behavior in a fixed year over a span of months)
- The columns of V are typical behaviors or modes in a fixed month over a span of years.
  - In both cases, the most important behaviors are listed first
- The diagonal matrix S contains the "importance" or "energy" or signal strength associated with each behavior

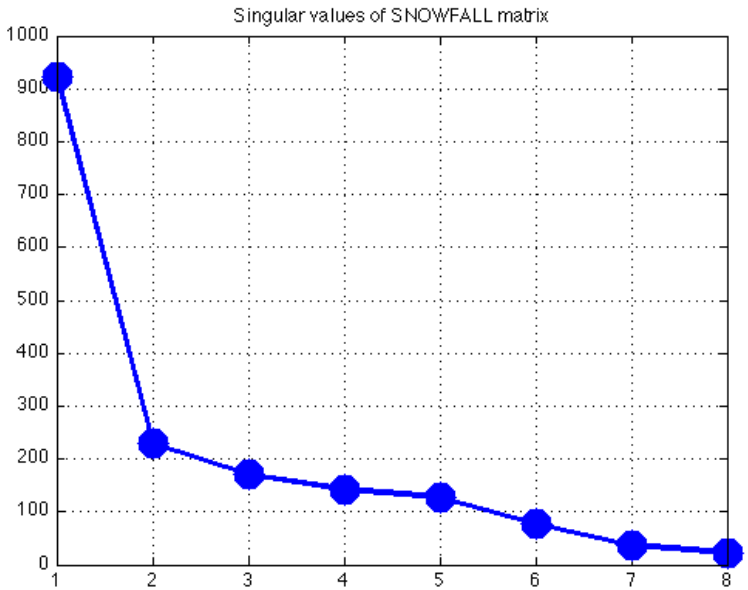
SVD example

The first 9 singular values

The S data shows the relative importance of the first two modes is:

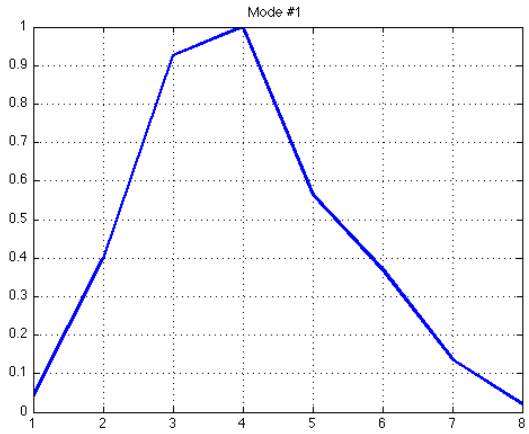
$$\frac{s1^2}{\sqrt{\sum_{i=1}^{8} s_i^2}} = 0.87 \qquad \frac{s2^2}{\sqrt{\sum_{i=1}^{8} s_i^2}} = 0.05$$

The first pair of modes, u_1 and v_1, by itself, can approximate the entire dataset with a relative accuracy of 87%.

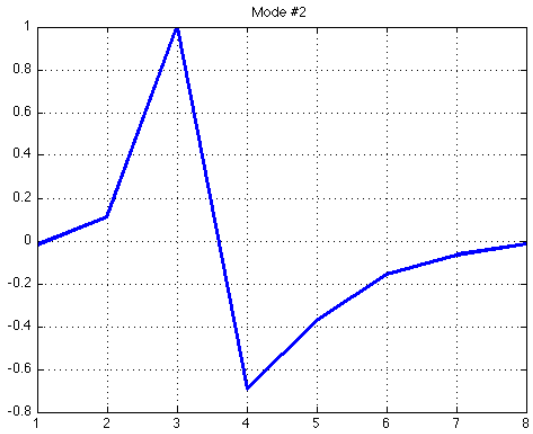


SVD example

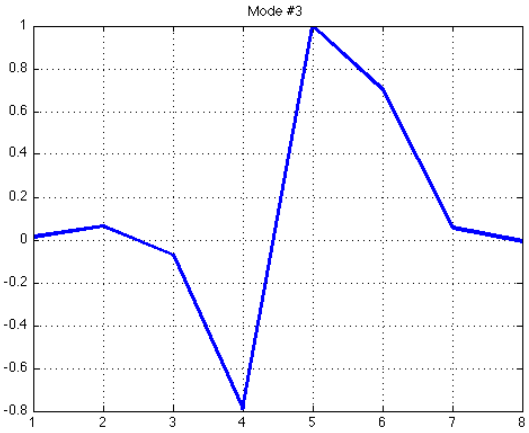
Four strongest snowfall modes for a year



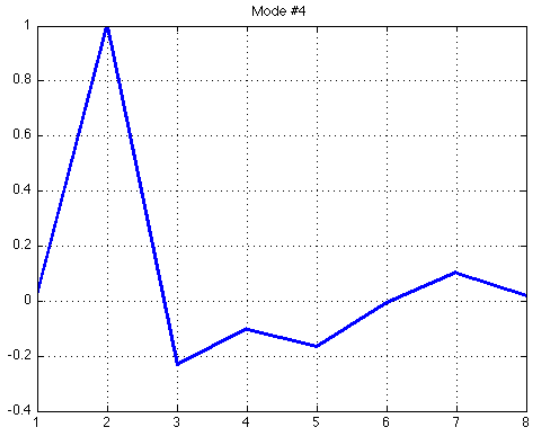
1 December/January High (DOMINANT)



2 More December, less later



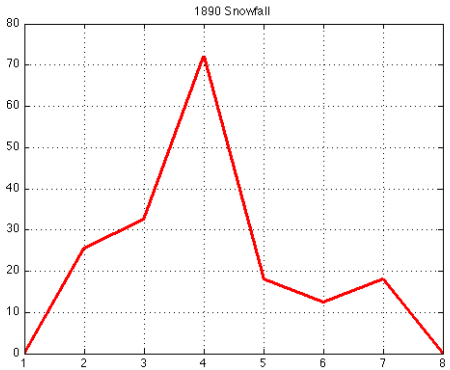
3 February High, less January



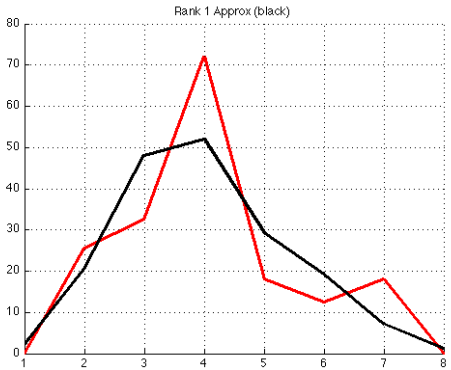
4 More November snow

SVD example

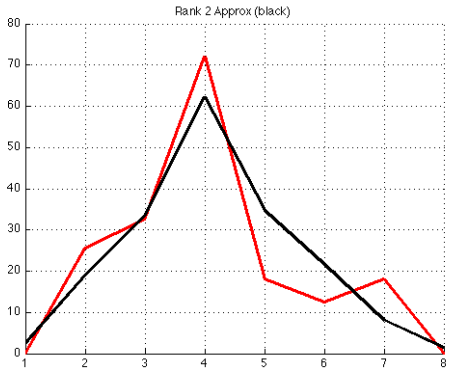
Approximating 2010-2011 snowfall



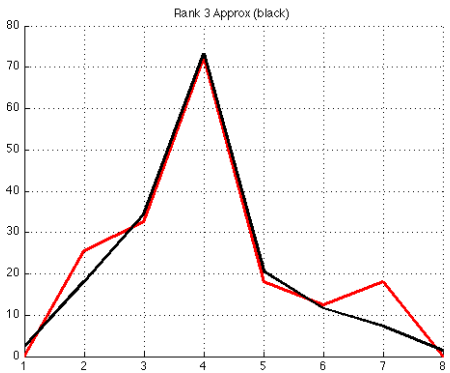
2010 – 2011 Data



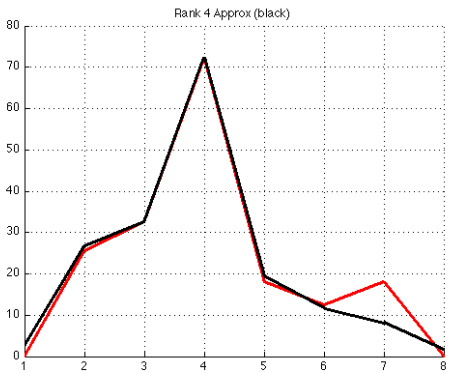
1 Mode



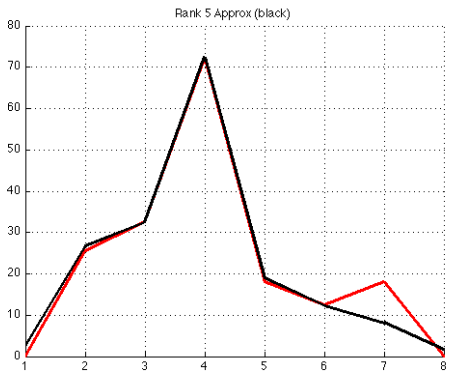
2 Modes



3 Modes



4 Modes



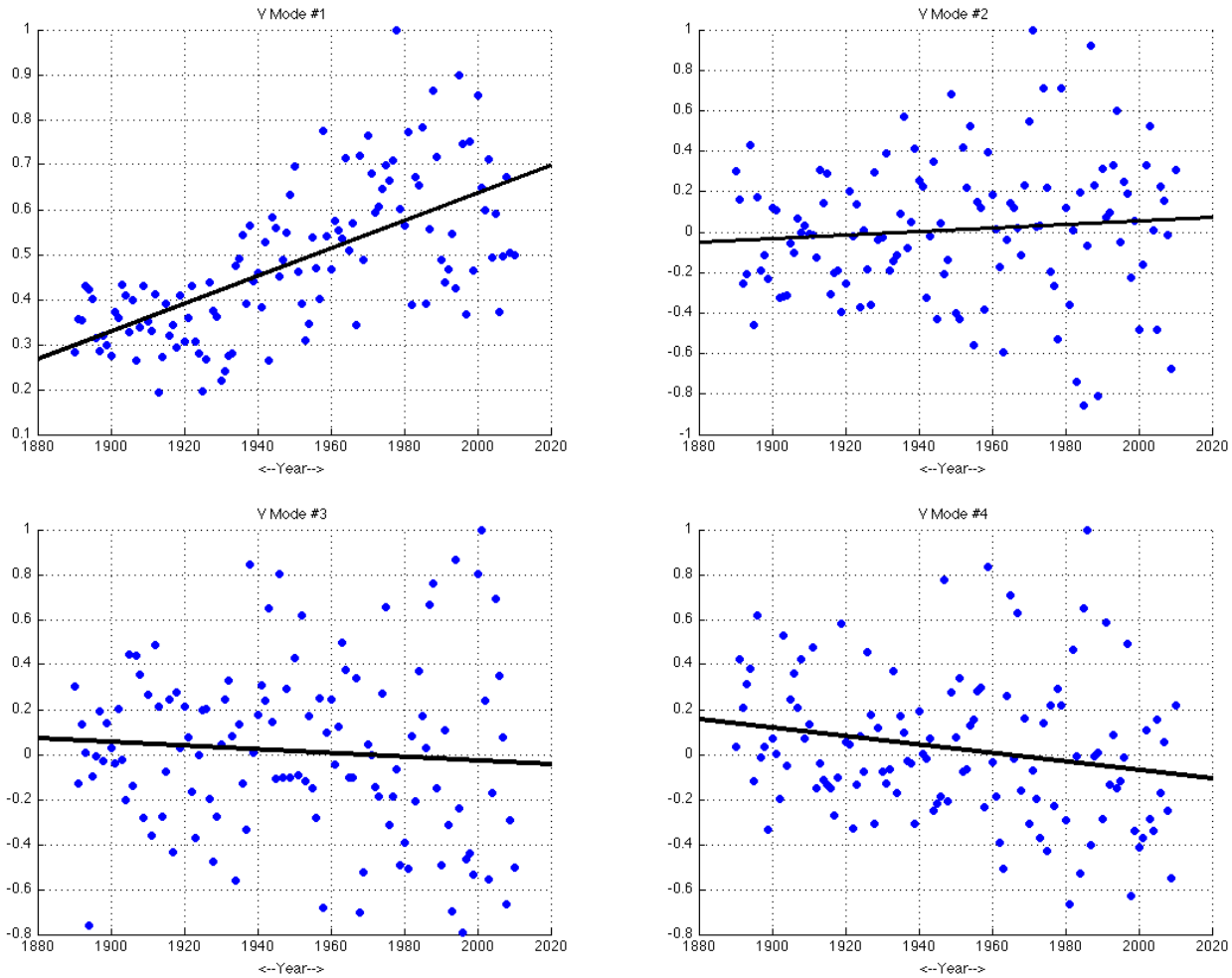
5 Modes

The same kind of approximating is occurring for all 121 sets of data!

SVD example

Four strongest "time" Modes

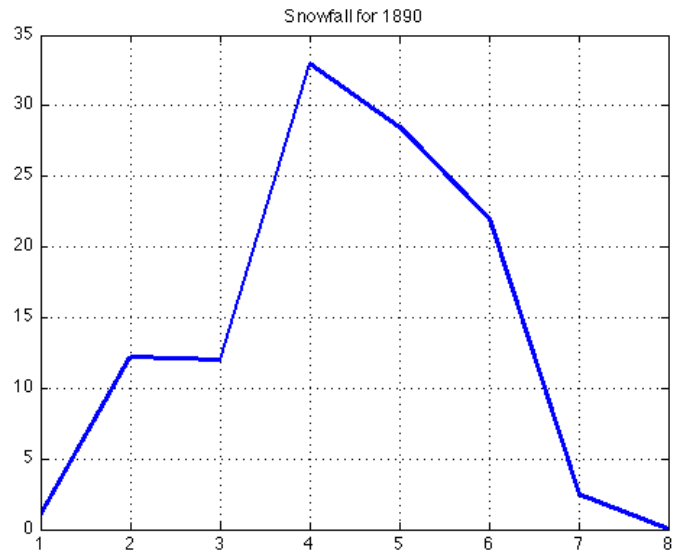
The linear regression line suggests the "December/January High" pattern (upper left) is steadily gaining importance over the years.

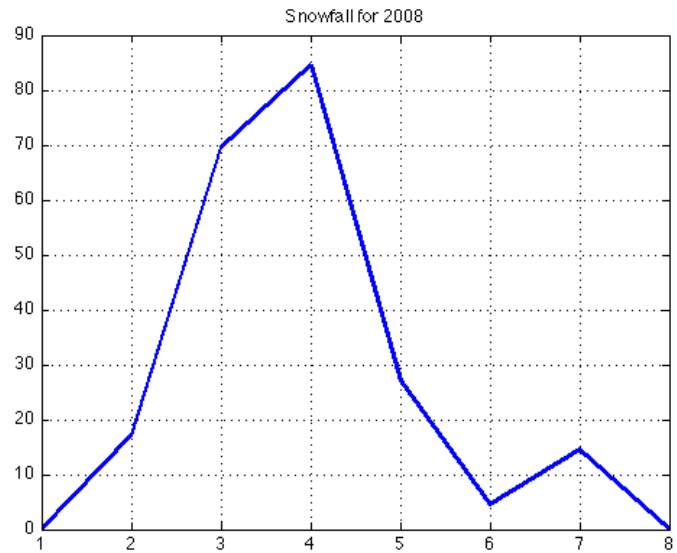


SVD

Typical old and new snowfall patterns

To see how heaviest snowfall is coming earlier, compare the 1890 January/February style snowfall with the 2008 December/January style:





SVD
Conclusions

1. Data gathered at discrete places and times is easier to understand than the corresponding continuous cases
2. The SVD shows how underlying patterns and correlations can be detected, and represented as a sum of the form

$$A = \sum_{i=1}^{r} \sqrt{\lambda_i}\, u_i\, v_i^T$$

   where the λ values represent a strength, the u's represent variation in space, and v variation in time
3. The structure of the u and v vectors suggests something about the preferred modes of the system, and the size of the λ coefficients allows us to understand the relative important of different modes, and to construct reduced order models if we wish

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SVD
Conclusions II

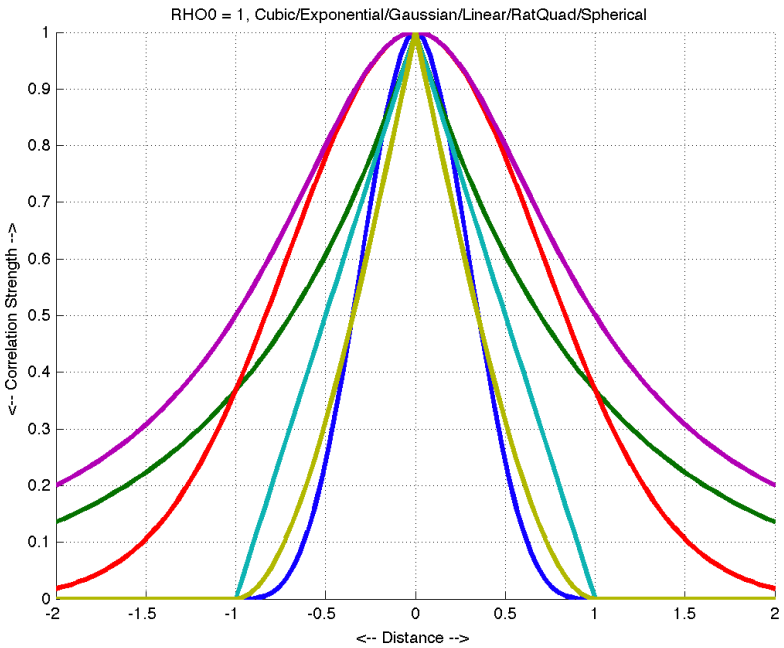
- Given that our data was stored in A, we may think of the matrices AA^T and A^TA as a form of a covariance matrix
- The singular values $\sqrt{\lambda_i}$ are the square roots of eigenvalues of both these matrices
- U contains eigenvectors of the "spatial" covariance matrix AA^T
- V contains eigenvectors of the "temporal" covariance matrix A^TA
- *Very similar statements will hold for the continuous case*

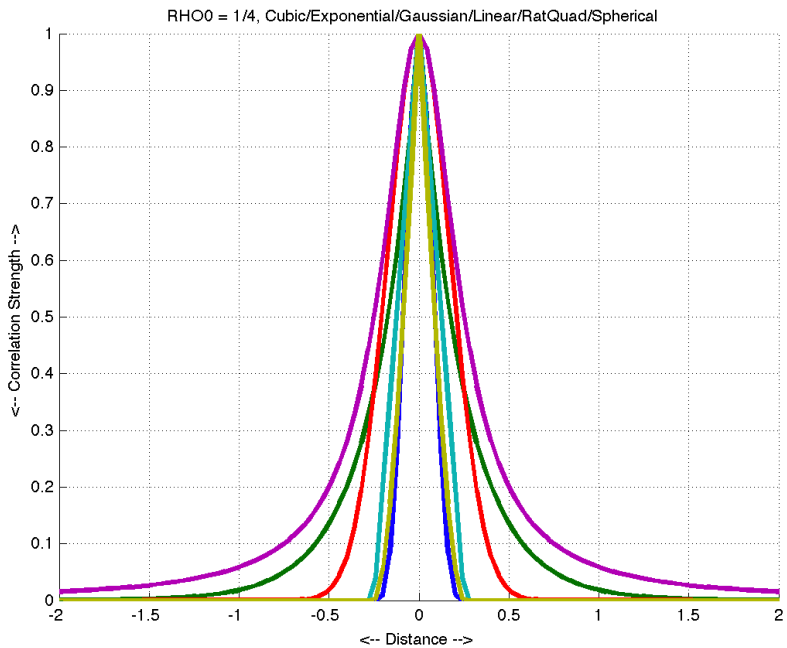
Stochastic representation of a RF

Karhunen-Loève expansion of the input data

The Karhunen-Loève expansion of a RF is a Fourier-type series based on the spectral expansion of its covariance function - other names Proper Orthogonal Decomposition (POD), Principle Component Analysis (PCA)

Let $a(\omega, x) \in L^2_{\mathbb{P}}$ be a RF with continuous covariance $\mathbb{C}_a : D \times D \to \mathbb{R}$





Examples of 1d covariance kernels for correlation lengths $L_c = 1$ and $L_c = 1/4$

Karhunen-Loève expansion

Properties of the covariance function

1. $\mathbb{C}_a$ **is symmetric**, i.e. $\mathbb{C}_a(x_1, x_2) = \mathbb{C}_a(x_2, x_1)$, $\forall x_1, x_2 \in D$
2. $\mathbb{C}_a$ **is non-negative definite**, i.e. for any $n = 1, \ldots$

$$\sum_{i=1}^{n}\sum_{j=1}^{n} \mathbb{C}_a(x_i, x_j) v_i v_j \geq 0, \forall (x_1, \ldots, x_n) \in D^n \text{ and } (v_1, \ldots, v_n) \in \mathbb{R}^n.$$

In matrix notation: $v^T \mathbb{C}_a(x, x) v \geq 0$, $\forall v, x$.

Define the associated linear covariance operator $T_{\mathbb{C}_a} : L^2(D) \to L^2(D)$ s.t.:

$$[T_{\mathbb{C}_a} f](x_1) = \int_D \mathbb{C}_a(x_1, x_2) f(x_2) dx_2, \forall f \in L^2(D)$$

Observation: $T_{\mathbb{C}_a} f \in C^0(D)$, $\forall f \in L^2(D)$, $\mathbb{C}_a \mapsto T_{\mathbb{C}_a}$ is injective and $T_{\mathbb{C}_a}$ is compact, symmetric and non-negative def.

- it has a countable sequence of real eigenvalues $\{\lambda_n\} \subset \mathbb{R}_+$, $\lambda_n \to 0$
- corresponding eigenfunctions $\{b_n(x)\}$ are $L^2(D)$-orthonormal

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Spectral representation of the kernel

Theorem (Mercer, 1909)

Given $\mathbb{C}_a$ continuous, symmetric, non-negative definite, then:

$$\lim_{N\to\infty} \max_{(x_1,x_2)\in D\times D} \left| \mathbb{C}_a(x_1,x_2) - \sum_{n=1}^{N} \lambda_n b_n(x_1) b_n(x_2) \right| = 0$$

Mercer's spectral representation of the kernel:

$$\mathbb{C}_a(x_1,x_2) = \sum_{n=1}^{\infty} \lambda_n b_n(x_1) b_n(x_2)$$

Eigenvalues/eigenfunctions constructed from a 2nd-order Fredholm equation:

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Approximating an ∞-dimensional RF

$$a(\omega, x) = \overline{a}(x) + \sum_{n=1}^{+\infty} b_n(x)\, Y_n(\omega),$$

$$\text{with } Y_n(\omega) = \int_D (a(\omega, x) - \overline{a}(x)) b_n(x)\, dx$$

- $(\lambda_n, b_n(x))$ are eigenpairs of $T_{\mathbb{C}_a}$; $Y_n(\omega)$ are centered, uncorrelated RVs:

$$\mathbb{E}[Y_n] = 0,\ \mathbb{C}ov[Y_n, Y_m] = \mathbb{E}[Y_n Y_m] = \delta_{nm}$$

but not necessarily independent, with $\mathbb{V}ar[Y_n] = \lambda_n$

If the basis $\{b_n\}$ has spectral approx. properties and the realizations of a are smooth, then $\lambda_n = \mathbb{V}ar[Y_n] \to 0$ sufficiently fast as $n \to \infty$ and we can truncate the series

$$a(\omega, x) \approx a_N(\omega, x) = \overline{a}(x) + \sum_{n=1}^{N} b_n(x)\, Y_n(\omega),$$

Rate of decay depends on the smoothness of $\mathbb{C}_a$ and the corr. length L_c

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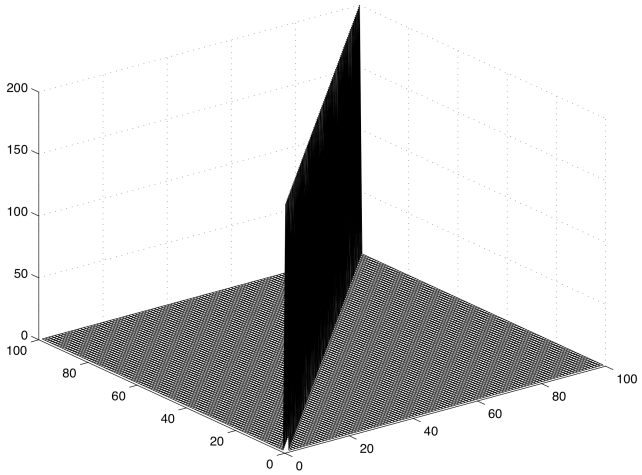
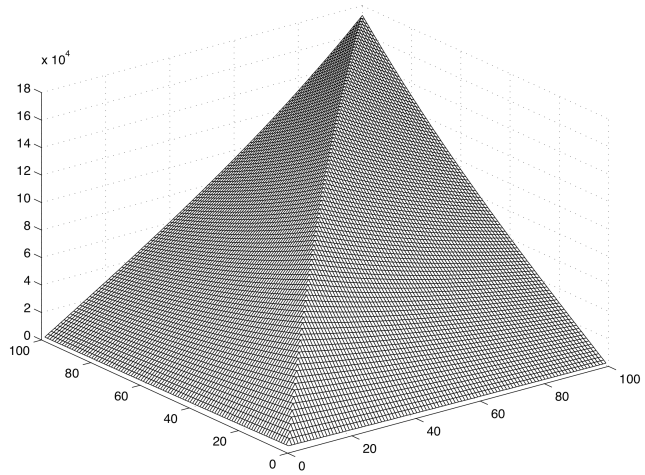
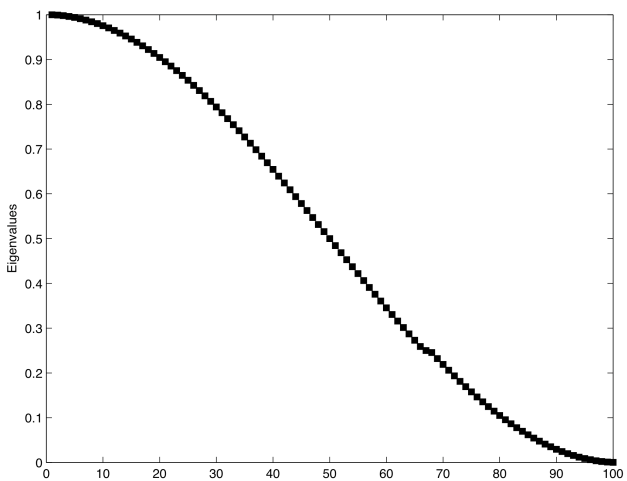
Karhunen-Loève expansion

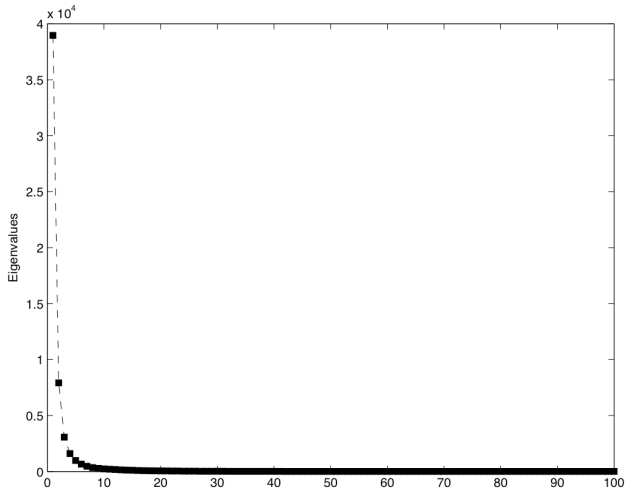
Example: Ornstein-Uhlenbeck process





Peaked and smooth covariance functions





Corresponding KL eigenvalues

Karhunen-Loève expansion

Truncation error minimization

This truncated expansion corresponds to the Best N-term approximation

$$\min_{\substack{(Y_n, b_n) \\ \int_D b_n b_m = \delta_{nm}}} \mathbb{E}\left[\int_D \left(a - \overline{a}(x) - \sum_{n=1}^{N} b_n Y_n\right)^2\right]$$

- If we truncate using the N largest eigenvalues, we have an optimal - in variance - expansion in N RVs
- i.e. with $\mathbb{C}_a$ continuous, a_N converges uniformly to a (Mercer's Thm)

$$\sup_{x \in D} E[(a - a_N)^2](x) = \sup_{x \in D} \left\{ \mathbb{C}_a(x) - \sum_{n=1}^{N} \lambda_n b_n^2(x) \right\} \to 0, \text{ as } N \to \infty$$

- KL expansion is the SVD of the map $A : L^2(D) \to L^2_{\mathbb{P}}(\Omega)$, where $\mathbb{C}_a := A^* A$ (i.e. truncate at the N largest eigenvalues of $A^T A$) $\Rightarrow$ finding a sparse representation (model reduction)

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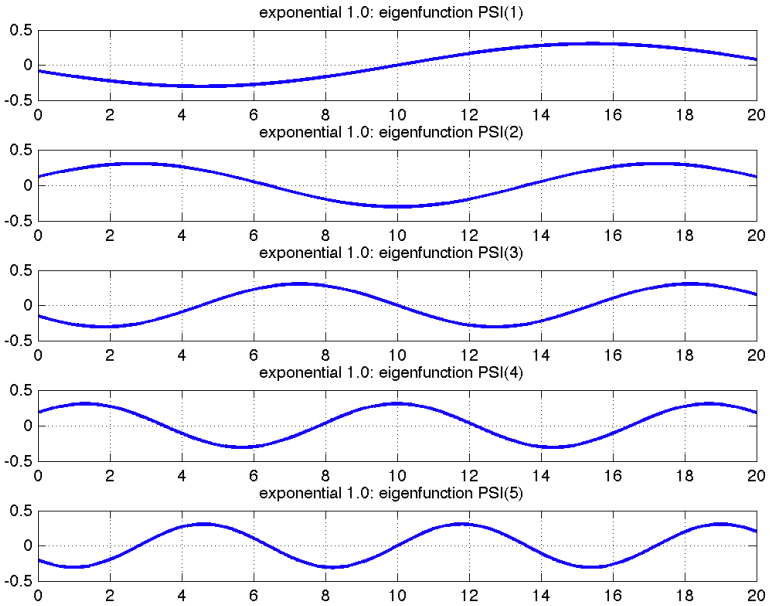
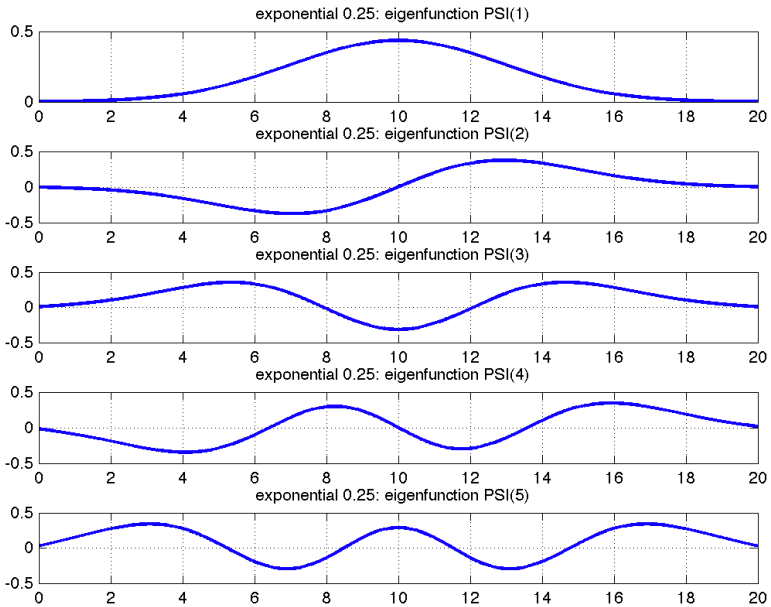
Karhunen-Loève expansion

Example eigenfunctions





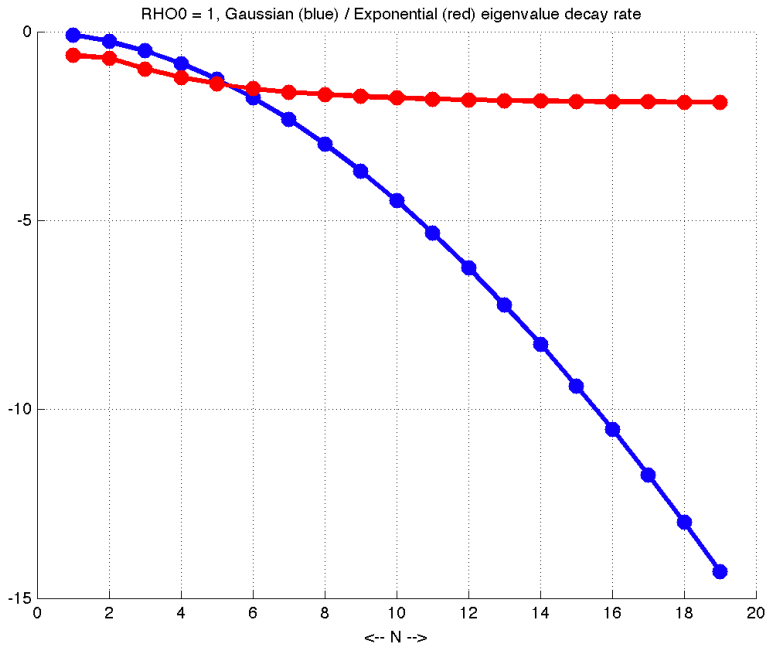
Distributions of the eigenfunctions of 1d exponential kernels,

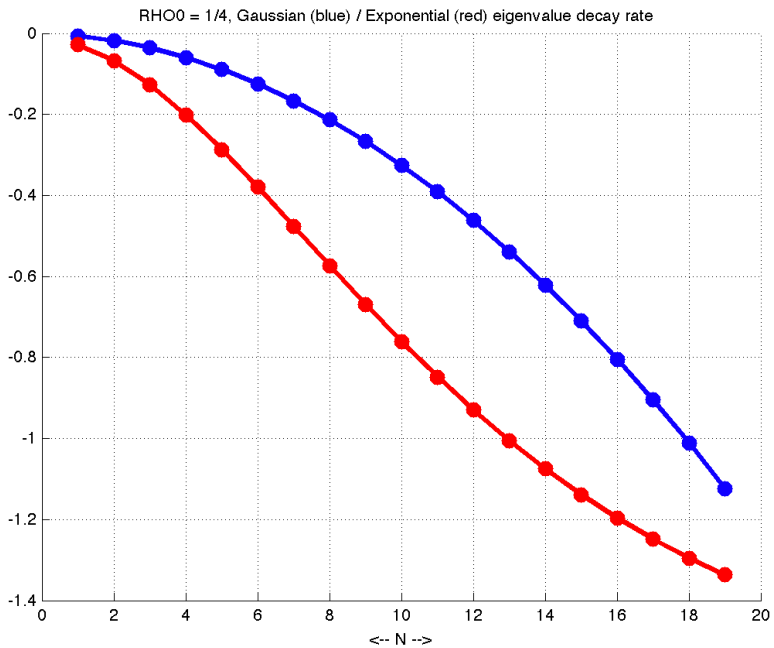
$\mathbb{C}_a(x_1, x_2) = \sigma^2 e^{-\frac{|x_1 - x_2|}{L_c}}$, for correlation lengths $L_c = 1$ and $L_c = 1/4$

Karhunen-Loève expansion

Examples of eigenvalues

exp.: $\mathbb{C}_a(x_1, x_2) = \sigma^2 e^{-\frac{\|x_1 - x_2\|_1}{L_c^2}}$, Gaussian: $\mathbb{C}_a(x_1, x_2) = \sigma^2 e^{-\frac{\|x_1 - x_2\|^2}{L_c^2}}$





Eigenvalues values of the kernels for correlation lengths $L_c = 1$ and $L_c = 1/4$

- More modes required as the correlation decreases (noise level increases)
- In the asymptotic limit of white noise $\Rightarrow$ infinity number of modes
- For a given L_c, the smoothness of the covariance kernel $\mathbb{C}_a$ dictates the convergence rate of the eigenvalues

Karhunen-Loève expansion

Convergence of the spectrum

- the truncation error decreases monotonically with the number of terms in the expansion
- the convergence is inversely proportional to the correlation length and depends on the regularity of the covariance kernel

Theorem (Schwab et al. 2005)

- If $\mathbb{C}_a$ is piecewise analytic on $D \times D$ with $D \subset \mathbb{R}^d$ then:

$$0 \leq \lambda_n \leq c_1 \exp(-c_2\ n^{1/d}), \quad \forall c_1, c_2 > 0 \text{ ind. of } n$$

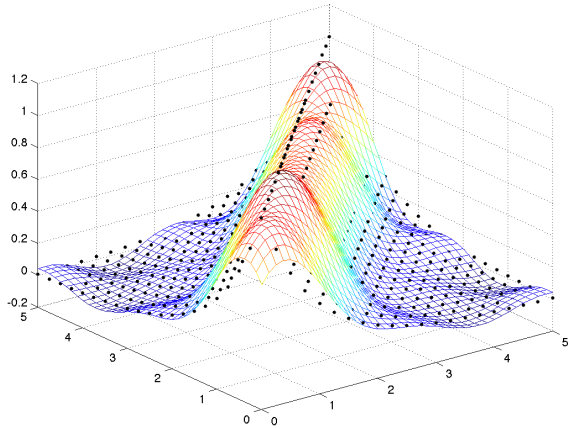
- If $\mathbb{C}_a$ is piecewise $H^k \otimes L^2$ with $k > 0$ then:

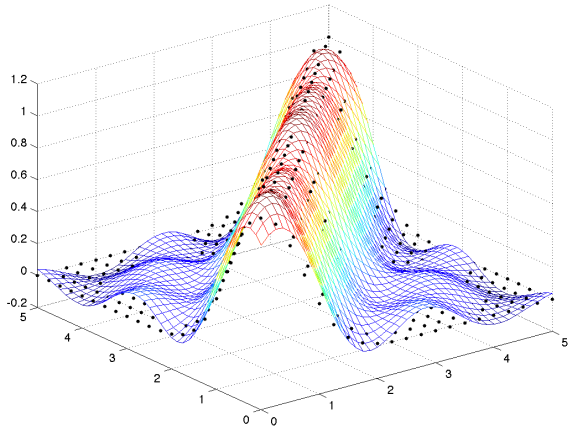
$$0 \leq \lambda_n \leq c_3\ n^{-k/d}, \quad \forall c_3 > 0$$

Remark: similar to SVD - if one wants the relative error (in the variance) less than some tolerance δ, i.e. $\|a - a_N\|^2 \leq \|a\|\,\delta$, then choose N s.t. $\sum_{n=N+1}^{\infty} \lambda_n \leq \delta \sum_{n=1}^{\infty} \lambda_n$

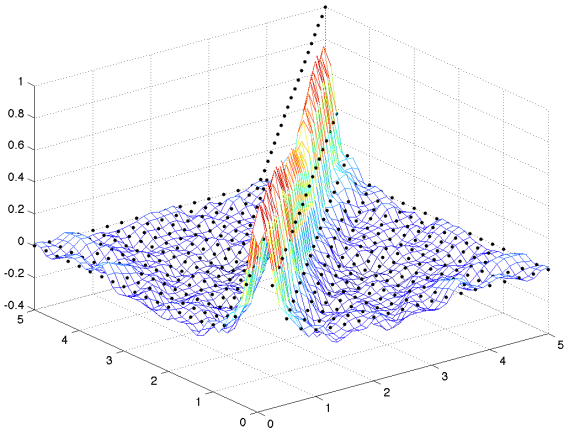
Karhunen-Loève expansion

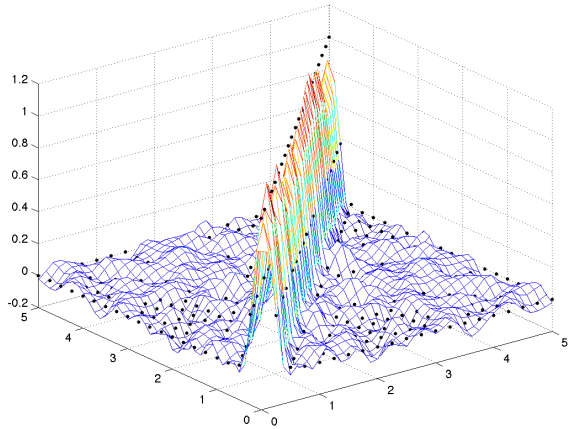
Approximating 90% variance with Gaussian kernel





Exponential and Gaussian kernels with $L_c = 1$ and $N = 5$ modes





Exponential and Gaussian kernels with $L_c = 1/4$ and $N = 20$ modes

Karhunen-Loève expansion

Special case: Gaussian RFs

Although the Y_n's are uncorrelated, in general they are not independent

- Gaussian RVs are uncorrelated $\Longleftrightarrow$ independent

A very convenient special case is the one where the RF $a(\omega, x)$ is a Gaussian RF, defined by Gaussian random vector $\mathbf{Y}(\mathbf{\Omega}) = \Gamma = \prod_n^N \Gamma_n$ s.t.

$$\rho(\mathbf{y}) = \prod_n^N \rho_n(y_n), \text{ where } y_n \in \Gamma_n$$

Question: Is a_N strictly positive? **Answer:** Not necessarily!

Warning: the truncated expansion might not be positive almost surely!
Possible remedy: nonlinear transformations

$$\Rightarrow a(\omega, x) \approx a_N(\omega, x) = a_{min} + e^{\gamma_N(\omega, x)} = a_{min} + e^{b_0(x) + \sum_{n=1}^N b_n(x) Y_n(\omega)}$$

where $\gamma_N(\omega, x)$ is a truncated Gaussian RF and $a_N(\omega, x)$ is a lognormal RF

Karhunen-Loève expansion

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Karhunen-Loève expansion

Stationary non-Gaussian RFs [Grigoriu, 2007]

- If $a(\omega, x)$ is the given RF and if the marginal CDF F_a is known or can be approximated, then one can use a translation process, i.e. a nonlinear transformation of a stationary Gaussian field $\gamma(\omega, x)$ with zero mean and unit variance:

$$a(\omega, x) = F_a^{-1} \circ \Phi(\gamma(\omega, x)),$$

  where Φ is the CDF of $N(0, 1)$

- then we can approximate $\gamma(\omega, x)$ using a truncated KL expansion in terms of Gaussian random parameters $\{Y_n(\omega)\}_{n=1}^N$ s.t.

$$a_N(\omega, x) = F_a^{-1} \circ \Phi(\gamma_N(\omega, x)) = F_a^{-1} \circ \Phi\left(b_0(x) + \sum_{n=1}^{N} b_n(x) Y_n(\omega)\right)$$

Summary

What's coming next?

- Motivation, Probabilistic and Stochastic models, aleatoric and epistemic uncertainty
- Formulating a "Plan of attack" for solving stochastic problems
- An overview of numerical methods for solving SPDEs
- Random variables and random fields
- Stochastic representation of a random field:
  - Discrete case, Singular value decomposition
  - Spectral expansion, Karhunen-Loève expansion
- What's next? Formulating a well-posed SPDE, stochastic regularity
- How to compute a numerical solution $u_N(\omega, x)$?
  - Monte Carlo FEM
  - Stochastic Galerkin FEM
  - Stochastic Collocation FEM
  - convergence analysis
- What happens when N becomes large?
  - curse of dimensionality and sparse representations